Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/621,074	LAM ET AL.	
Examiner	Art Unit	
Sun J Lin	2825	

	SEARCHED				
Class	Subclass	Date	Examiner		
716	·1	2/22/2005	JSL		
716	16	2/22/2005	JSL		
716	17	2/22/2005	JSL		
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INTERFERENCE SEARCHED				
Class .	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB	2/22/2005	JSL
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB	6/30/2005	JSL
EAST (USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB	7/11/2005	JSL
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB	7/20/2005	JSL
IEEE	6/30/2005	JSL
GOOGLE	7/11/2005	JSL